

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

Patent no.: **7,139,295**  
Issue date: **Nov. 21, 2006**

Patentee: **Tsai et al.**  
For (title): **TUNABLE WAVELENGTH LOCKER, TUNABLE WAVELENGTH SPECTRUM MONITOR, AND RELATIVE WAVELENGTH MEASUREMENT SYSTEM**

**Commissioner for Patents**  
**P.O. Box 1450**  
**Alexandria, Virginia 22313-1450**

**LETTER CALLING ATTENTION TO ERRORS IN PATENT**

Sir:

The following errors appear in this patent:

1. At column 2, line 53 the text “a thermal” should read “athermal”
2. At column 7, lines 27, 28, 34 and 35 the character printed as “□” should read “λ”
3. At column 7, line 43 the character printed as “□” should read “Δ”

With respect to (1), this appears to be an ad hoc change by Office staff in preparing the patent to issue. With respect to (2) and (3), these were submitted correctly in the XML format used by the Office at the time the application was filed electronically and appear to be errors that were introduced when the Office later converted the XML version to PDF format.

We respectfully ask that a copy of this letter be placed in the file for this patent.

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Respectfully Submitted,



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